

# Tech Note T23: Probabilistic error cancellation: paper notes

Summary for key notation of *Probabilistic error cancellation with sparse Pauli-Lindblad models on noisy quantum processors* [Ref. van den Berg et al. (2020)]

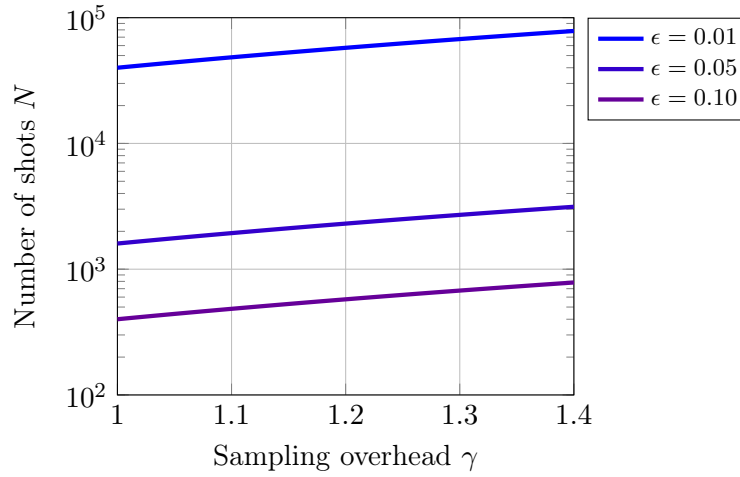
Symbol	Description	Value
<b>Circuit constants &amp; indices</b>		
$n$	number of qubits in circuit	$n = 1, 2, 3, \dots$
$l$	number of layers in circuit	$l = 1, 2, 3, \dots$
$i$	layer index within circuit	$i = 1, \dots, l$
<b>Pauli-Lindblad model inputs</b>		
$k$	model coefficient index, corresponds to a Pauli	$k = 1, 2, 3, \dots$ or equiv. $n$ -qubit Pauli string
$b$	fidelity vector indices	$b = 1, 2, \dots$ or equiv. $n$ -qubit Pauli string
$\mathcal{K}$	set of Pauli fidelity support indices for the sparse model $\mathcal{L}$ of $\Lambda$ . Small set	$k \in \mathcal{K}$
$\mathcal{B}$	set of benchmark Paulis (Pauli fidelity support indices of $\Lambda$ ). Can be all of them, big set	$b \in \mathcal{B}$
$N$	number of error-mitigated circuit instances	$N = 1, 2, 3, \dots$
<b>Pauli-Lindblad model variables</b>		
$\gamma$	sampling overhead	$\gamma \geq 1, \gamma = \exp(\sum_{k \in \mathcal{K}} 2\lambda_k)$
$\gamma_i, \gamma(l)$	sampling overhead for the $i$ -th layer and a total of $l$ layers	$\gamma(l) = \prod_{i=1}^l \gamma_i$
$\lambda_k$	$k$ -th model coefficient	$\lambda_k \geq 0$
$w_k$	noise model weight in $\Lambda$ factoring	$w_k := \frac{1}{2} (1 + e^{-2\lambda_k})$
$f_b$	Pauli $\Lambda$ fidelity of $b$ -th Pauli index	$f_b := \frac{1}{2^n} \text{Tr} \left( P_b^\dagger \Lambda(P_b) \right)$
$f$	vector of Pauli fidelities of $\Lambda$	$f = \{f_b\}_{b \in \mathcal{B}}$
$\hat{f}$	fidelity estimates for a set of	
$M(\mathcal{B}, \mathcal{K})$	binary matrix with entries $M_{b,k} = \langle b, k \rangle_{sp}$ where the symplectic product is 0 is the Paulis commute and 1 if they do not	$\log(f) = -2M(\mathcal{B}, \mathcal{K})\lambda$ (element-wise log) (used to fit with $\lambda \geq 0$ )
<b>Quantum operators and superoperators</b>		
$P_k$	Pauli operator, indexed by $k$	$P_k \in \{I, X, Y, Z\}^{\otimes n}$
$U, \mathcal{U}, \tilde{\mathcal{U}}_i$	unitary ideal gate; tilde: noisy $i$ -th layer unitary	
$\Lambda, \Lambda_i$	noise channel	$\Lambda(\rho) = \exp[\mathcal{L}](\rho) = \prod_{k \in \mathcal{K}} \left( w_k \cdot + (1 - w_k) P_k \cdot P_k^\dagger \right) \rho$
$\Lambda^{-1}$	inverse noise map	$\Lambda^{-1}(\rho) = \exp[-\mathcal{L}](\rho) = \prod_{k \in \mathcal{K}} \left( w_k \cdot - (1 - w_k) P_k \cdot P_k^\dagger \right) \rho$
$\mathcal{L}(\rho)$	Lindblad generator	$\mathcal{L}(\rho) = \sum_{k \in \mathcal{K}} \lambda_k (P_k \rho P_k - \rho)$
$\langle \hat{A}_N \rangle$	average error mitigated estimate of $\langle \hat{A} \rangle$ for some operator $\hat{A}$ using $N$ circuit instances	

## 23.1 Common questions

**How many random circuits to run?** For a maximum error bound  $\epsilon$  between the the ideal and mitigated expectation values  $\left| \langle \hat{A} \rangle_{\text{ideal}} - \langle \hat{A}_N \rangle \right| \leq \epsilon$  satisfied with a probability  $1 - \delta$  (assuming a weak enough noise,  $C^{l\tau} \approx 1$ ), we can solve for the number of error-mitigated, random circuit instances  $N$  in van den Berg et al. (2020)

$$\epsilon = \gamma \frac{\sqrt{2 \log(2/\delta)}}{\sqrt{N}},$$
$$\therefore N = 2 \log(2/\delta) \left( \frac{\gamma}{\epsilon} \right)^2,$$
$$N \approx 4 \left( \frac{\gamma}{\epsilon} \right)^2 \quad \text{for } \delta \sim 0.01.$$

For probability  $\delta = 2\%$ ,  $\log(2/\delta) = 2$ , a small overhead; for  $\delta = 0.01$ , it is 2.3, and for  $\delta = 0.001$ , it is 3.3.



### Bibliography

E. van den Berg, Z. K. Mineev, and K. Temme, arXiv (2020), ISSN 23318422, 2012.09738, URL <http://arxiv.org/abs/2012.09738>.  
Nature Physics **16**, 233 (2020), ISSN 1745-2473, URL <https://doi.org/10.1038/s41567-020-0847-3><http://www.nature.com/articles/s41567-020-0847-3>.

**Caveat emptor** These pages are a work in progress, inevitably imperfect, incomplete, and surely enriched with typos and unannounced inaccuracies. Sources credited in Bibliography to the best of my ability, though certain omissions certainly remain.

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